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## AON6405

## 30V P-Channel MOSFET

## **General Description**

The AON6405 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

## **Product Summary**

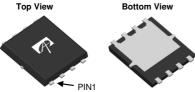
 $\begin{array}{ll} V_{DS} & -30 \\ I_{D} \; (at \; V_{GS} \!\!=\! -10V) & -30A \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! -10V) & <7m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! -4.5V) & <8m\Omega \end{array}$ 

#### **ESD Protected**

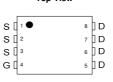
100% UIS Tested

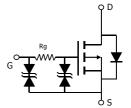


# **DFN5X6**Top View



#### Top View





## Absolute Maximum Ratings T<sub>A</sub>=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	-30	V	
Gate-Source Voltage		V <sub>GS</sub>	±20	V	
Continuous Drain T <sub>C</sub> =25℃			-30		
Current <sup>G</sup>	T <sub>C</sub> =100℃	I <sub>D</sub>	-23	A	
Pulsed Drain Current <sup>c</sup>		I <sub>DM</sub>	-160		
Continuous Drain Current	T <sub>A</sub> =25℃	ı	-15	A	
	T <sub>A</sub> =70℃	IDSM	-12	^	
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	-54	A	
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub>	146	mJ	
	T <sub>C</sub> =25℃	P <sub>D</sub>	83	W	
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100℃	L D	33	VV	
	T <sub>A</sub> =25℃	P <sub>DSM</sub>	2.5	W	
Power Dissipation <sup>A</sup>	T <sub>A</sub> =70℃	DSM	1.6	VV	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C	

Thermal Characteristics									
Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	14.2	17	℃/W				
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	42	50	°C/W				
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.2	1.5	℃/W				



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, \ V_{GS} = 0 V$	-30			V				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V			-1	μA				
		T <sub>J</sub> =55℃			-5	μιτ				
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0V$ , $V_{GS}=\pm 16V$			±10	μΑ				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=-250\mu A$	-0.8	-1.2	-1.6	V				
$I_{D(ON)}$	On state drain current	$V_{GS}$ =-10V, $V_{DS}$ =-5V	-160			Α				
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A		5.5	7	mΩ				
		T <sub>J</sub> =125℃		7	8.5	11122				
		$V_{GS}$ =-4.5V, $I_{D}$ =-20A		6.1	8	mΩ				
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =-5V, $I_{D}$ =-20A		70		S				
$V_{SD}$	Diode Forward Voltage	$I_S=-1A, V_{GS}=0V$		-0.65	-1	V				
Is	Maximum Body-Diode Continuous Curr			-30	Α					
DYNAMIC	PARAMETERS									
C <sub>iss</sub>	Input Capacitance			4580	5500	pF				
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =-15V, f=1MHz		755		pF				
$C_{rss}$	Reverse Transfer Capacitance			564		pF				
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		160	210	Ω				
SWITCHI	NG PARAMETERS									
Q <sub>g</sub> (10V)	Total Gate Charge			87	105	nC				
Q <sub>g</sub> (4.5V)	Total Gate Charge	V 10V V 15V L 20A		41		nC				
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =-10V, $V_{DS}$ =-15V, $I_{D}$ =-20A		12.8		nC				
$Q_{gd}$	Gate Drain Charge	1		17		nC				
t <sub>D(on)</sub>	Turn-On DelayTime			180		ns				
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =-10V, $V_{DS}$ =-15V,		260		ns				
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_L=0.75\Omega$ , $R_{GEN}=3\Omega$		1.2		μs				
t <sub>f</sub>	Turn-Off Fall Time	7		9.7		μs				
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-20A, dI/dt=300A/μs		32	40	ns				
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-20A, dI/dt=300A/μs		77		nC				

A. The value of  $R_{0JA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$  C. The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of  $150^{\circ}$  C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub> =25° C.Maximum UIS current limited by test equipment.

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

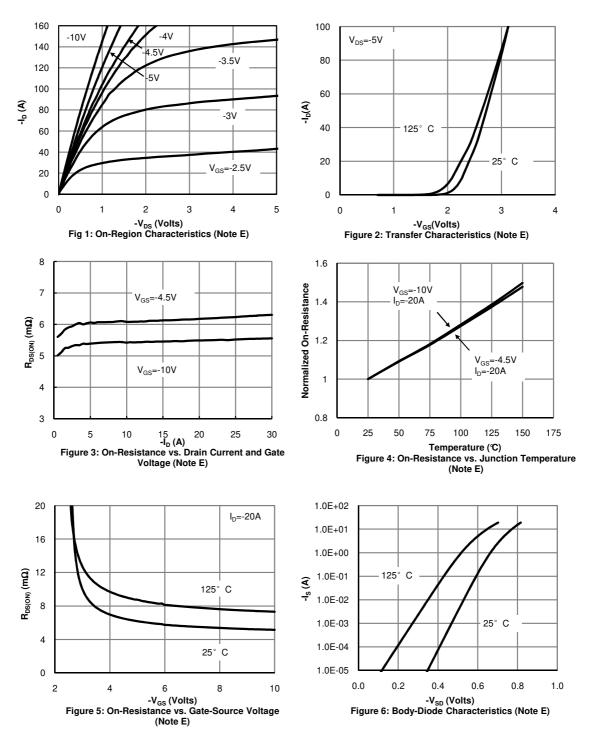
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

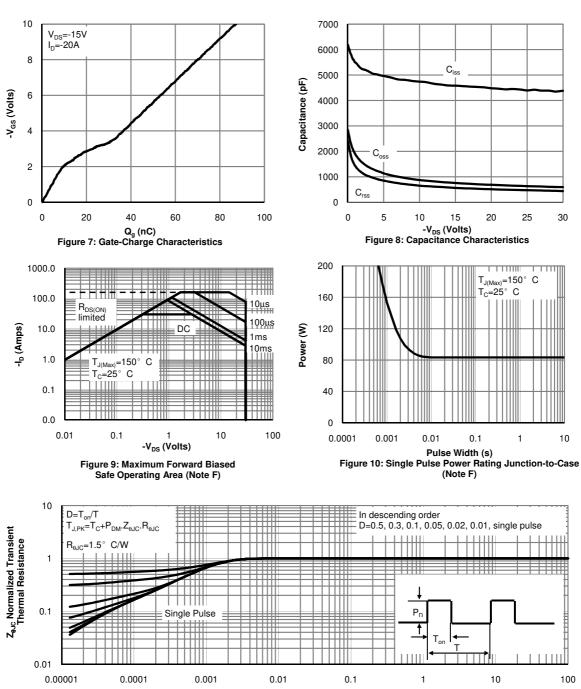


#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





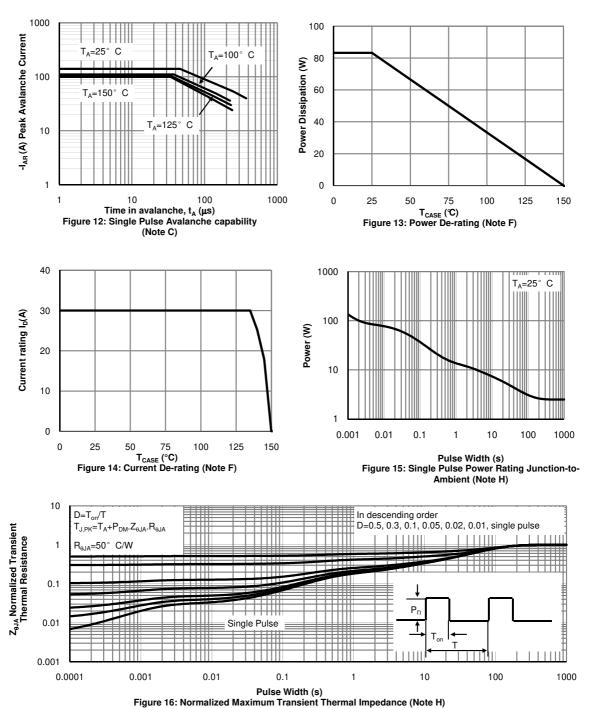
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



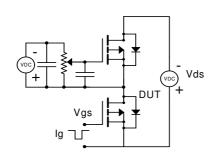
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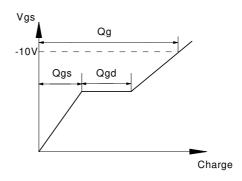


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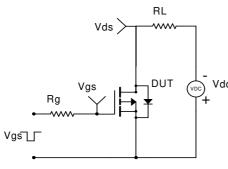


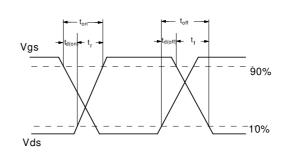
## Gate Charge Test Circuit & Waveform



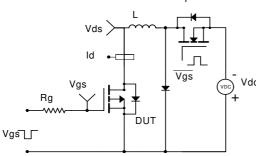


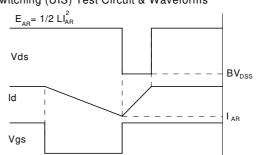
## Resistive Switching Test Circuit & Waveforms





## Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms

